Photonic and Plasmonic Guided Modes in Graphene-Silicon Photonic Crystals

Gu, Tingyi; Andryieuski, Andrei; Hao, Yufeng; Li, Yilei; Hone, James; Wong, Chee Wei; Lavrinenko, Andrei; Low, Tony; Heinz, Tony F.

Published in:
A C S Photonics

Link to article, DOI:
10.1021/acsphotonics.5b00209

Publication date:
2015

Document Version
Publisher's PDF, also known as Version of record

Link back to DTU Orbit

Citation (APA):
Photonic and Plasmonic Guided Modes in Graphene–Silicon Photonic Crystals

Tingyi Gu, Andrei Andryieuski, Yufeng Hao, Yile Li, James Hone, Chee Wei Wong, Andrei Lavrinenko, Tony Low, and Tony F. Heinz

ABSTRACT: We report the results of systematic studies of plasmonic and photonic guided modes in large-area single-layer graphene integrated into a nanostructured silicon substrate. The interaction of light with graphene and substrate photonic crystals can be classified in distinct regimes depending on the relation of the photonic crystal lattice constant and the relevant modal wavelengths, that is, plasmonic, photonic, and free-space. By optimizing the design of the substrate, these resonant modes can increase the absorption of graphene in the infrared, facilitating enhanced performance of modulators, filters, sensors, and photodetectors utilizing silicon photonic platforms.

KEYWORDS: graphene absorption, graphene plasmonic response, silicon photonics, infrared response, absorption enhancement

The continuous miniaturization of components in silicon photonics provides a platform to enable applications in densely integrated communication and computing systems. The high refractive index and low absorption of silicon allow for low-loss waveguiding from the terahertz to the telecommunication spectral range in the near-infrared, but its band gap of 1.1 eV renders silicon an inefficient material for photodetection in this long wavelength range. Hence, photonic systems based on alternative materials, such as III–V semiconductors and graphene, are sought for those applications. In particular, graphene is a promising material since it supports mid-infrared plasmons with light confinement down to 1/100 of the free-space wavelength $\lambda_0$, as well as tunability of electrical conductivity, thus, allowing the creation of active devices not possible with conventional metal plasmonics. Graphene plasmons have already been experimentally observed and explored for terahertz and infrared absorption, modulation, photodetection, and chemical sensing. Furthermore, graphene can be easily integrated with silicon photonics components for more efficient light management schemes.

One of the challenges for the excitation and use of surface plasmon polaritons in graphene is the phase (wavevector) mismatch between these guided waves and the incident electromagnetic radiation. Graphene nanostructures, such as one-dimensional (1D) nanoribbon arrays and two-dimensional (2D) rectangular resonator arrays, dot and antidot lattices and plasmonic crystals, provide a natural approach to coupling free-space radiation to graphene plasmons. However, these schemes require that the graphene layer be patterned, which introduces additional loss channels from atomic scale roughness of the edges. It is therefore attractive to couple to graphene plasmons by the alternate approach of patterning the substrate, leaving the graphene layer in its pristine state and preserving its excellent electronic properties.

The case of a 1D grating etched into a silicon substrate with a graphene overlayer has been studied theoretically for mid-IR plasmon excitation and subsequently investigated experimentally in a hexagonal 2D grating configuration. These configurations exploit the difference in the effective mode index between plasmons in a silicon–graphene–air structure (graphene on silicon) and in a suspended air–graphene–air structure (graphene over holes), in addition to using the associated contrast of the dynamic conductivity. At the same time, photonic modes within the silicon grating can also be excited. These photonic modes can be used to increase the absorbance in graphene, as was recently demonstrated. In this work, we explore the various regimes of light–matter interaction in the infrared spectral range for graphene integrated with a silicon photonic crystal membrane.
We consider the typical regime for which the graphene plasmonic modes and to the photonic guided modes of the underlying substrate. We examine theoretically the physical mechanisms and factors controlling the crossover between these regimes.

**STRUCTURES INVESTIGATED AND THEIR CLASSIFICATION**

A scanning electron micrograph of a representative structure consisting of graphene on a photonic crystal membrane is presented in Figure 1a. The different regimes of light coupling to the structure can be categorized based on the feature size of the structure (particularly the lattice constant \(a\)), the effective wavelengths for the plasmonic (\(\lambda_{pl}\)) and photonic crystal (\(\lambda_{pc}\)) modes, and the incident (vacuum) wavelength of the light (\(\lambda_0\)). We consider the typical regime for which \(\lambda_{pl} < \lambda_{pc} < \lambda_0\) and assume incident light from the vacuum. We identify four regimes of interest:

1. \(a < \lambda_{pl}\): **Metamaterial Regime.** In order to excite a guided wave efficiently at normal incidence, the distance between scatterers in a periodic array should be equal to an integral multiple of the effective wavelength of the guided mode. This condition clearly cannot be met in the of \(a < \lambda_{pl}\) and we can consequently consider graphene as a plasmonic metamaterial (or metasurface), since no guided surface waves can be excited due to the pronounced phase mismatch. The incident wave can only be reflected, transmitted, and absorbed in the graphene layer. (Absorption in silicon substrate is low for the relevant spectral range.) The structured silicon substrate can be considered as a homogeneous layer with an anisotropic dielectric response.\(^{34}\)

2. \(\lambda_{pl} < a < \lambda_{pc}\): **Plasmonic Regime.** In this regime, in addition to transmission and reflection of the incident radiation, coupling of the incident light to plasmonic modes becomes possible at certain frequencies. This coupling occurs when phase matching is achieved, i.e., for incident waves with propagation constant \(\beta = qk_0 = (2\pi/a)m\), where \(q\) is the effective mode index, \(k_0 = 2\pi/\lambda_0\) is the free-space wavevector of the light, and \(m\) is an integer. The incident wave couples to graphene plasmons that are tightly confined by the graphene layer. Their energy is partially absorbed by the graphene and partially coupled back to free space.

3. \(\lambda_{pc} < a < \lambda_0\): **Photonic Regime.** In addition to the aforementioned channels, in this regime, the incident wave can couple to the photonic modes of the membrane. Radiation is then absorbed by graphene, which acts mostly as a lossy medium. The photonic modes depend not only on the grating lattice constant, but also on the thickness of the silicon layer. Since we assume light coupling from a normally incident plane wave, we are concerned with the photonic modes that are normally considered as leaky.

4. \(\lambda_0 < a\): **Diffraction Grating Regime.** In this regime, the periodic structure becomes a diffraction grating and the incident power is distributed among various diffraction orders, in addition to excitation of the photonic and plasmonic modes described above.

We note that for sufficiently large lattice constant \(a\), all these types of coupling are possible simultaneously, though they are usually important in different frequency ranges. The metamaterial regime for absorbers is well-known,\(^{35}\) while the diffraction grating regime is not particularly suitable for absorbers, since the incident power is predominantly scattered back into free space. In this work, we consequently explore both experimentally and theoretically the most interesting plasmonic and photonic regimes (see illustration in Figure 1a).
Hexagonal 2D silicon photonic crystal membranes were fabricated on a 250 nm thick silicon-on-insulator layer by deep ultraviolet photolithography (248 nm) and etched to reduce disorder scattering. The silicon layer is intrinsic, with an estimated doping level of $10^{15}$ cm$^{-3}$. The lattice constant of the photonic crystal was chosen as 415 nm, with hole radii varying from 80 to 140 nm in 10 nm steps, corresponding, respectively, to silicon filling fractions of 0.87–0.59. The sacrificial release of the supporting silicon oxide buffer layer was performed by wet etching, resulting in a 0.5 μm air gap between photonic crystal membrane and the underlying silica substrate (Figure S1).

Large-area graphene monolayers were grown on copper foil by a chemical vapor deposition (CVD) process. The thickness and crystallinity of the graphene layers were characterized by means of Raman spectroscopy (data not shown). The graphene layers were then transferred onto patterned photonic crystal substrates by a PMMA-assisted method (Figure 1a,b). The resulting morphology of the graphene layers was examined by atomic force microscopy (AFM). These measurements yielded an apparent height difference of 0.89 nm between the regions of graphene supported by silicon and those suspended over holes (Figure 1c). The fwhm of the AFM peak provides an indication of the surface roughness of the graphene samples. Based on these measurements, the roughness of suspended and supported graphene layers was found to be 1.72 and 5.31 nm, respectively, indicating that the transferred graphene was of reasonably good quality. The contrast in the surface stiffness of the suspended and supported regions of the graphene sample was used to map the overall structure (Figure 1d). The formation of graphene-silicon antidot arrays with a fixed lattice constant $a$ and increasing hole radii $r$ was identified by the surface stiffness mapping technique [Figure 1d (i–vi)]. The hexagonal symmetry was present for all samples, with limited disorder from polymer residues, as shown in Figure 1d (i–vi) and in the corresponding two-dimensional Fourier transforms in Figure 1d (i–vi).

In order to isolate the contribution of the graphene layer to the optical response of the patterned substrate, we selectively etched away half of the graphene layer using an oxygen plasma (see Supporting Information, Figure S5a). We determined the precise position of the graphene on the substrate by Raman spectroscopy (Figure S5b), making use of the fact that a free-standing graphene monolayer exhibits a stronger Raman signal than that of a supported graphene monolayer.

For broadband optical characterization of the structure in the infrared, we probed the response of the sample using a commercial Fourier transform infrared spectrometer (Vertex, Bruker Optics), collecting the IR spectra in a reflection geometry. To this end broadband light from a thermal source was directed onto the sample at normal incidence through an aperture of 100 μm × 20 μm size. We then measured the reflectance $R$ from the graphene-covered structure and the reflectance $R_0$ from an uncovered reference region of the photonic crystal. We characterize the influence of the graphene by its extinction ratio $ER$ inferred from the reflectivity measurements: $ER = 1 - R/R_0$.

The reflectance from the graphene-covered and uncovered reference structures (Figure S1) were simulated using the CST Microwave Studio package with the time-domain solver under the assumption of periodic boundary conditions. The relevant optical properties of silicon and silica (see Supporting Information, Figure S2a,b) were taken from the refs 41 and 42, respectively. The response of the graphene monolayer was modeled as a sheet of thickness of Δ = 1 nm, with an effective dielectric permittivity of $\varepsilon_r(\omega) = 1 + \sigma(\omega)/\varepsilon_0\omega\Delta$, where $\omega$ is the angular frequency and $\sigma(\omega)$ is the sheet conductivity of graphene. For the latter, we made use of the expression from ref 43 (see Supporting Information for further details), which includes both the intra- and interband contributions to the conductivity and also accounts for the effects of the finite temperature $T$:

$$\sigma(\omega) = \frac{2e^2k_B T}{\pi \hbar^2} \ln \left[ \frac{2 \cosh \left( \frac{E_F}{k_B T} \right)}{\omega - i \frac{\gamma}{\pi}} \right] + \frac{e^2}{4\hbar} \left[ H\left( \frac{\omega}{2} \right) + \frac{4i\omega}{\pi} \int_0^\infty dx \frac{H(x) - H\left( \frac{\omega}{2} \right)}{x^2 - 4x^2} \right]$$

where $H(x) = \frac{\sinh(hx/k_B T)}{\cosh(E_F/k_B T)} + \frac{\cosh(hx/k_B T)}{\sinh(hx/k_B T)} = \frac{1}{2} \left[ \tanh \left( \frac{hx + E_F}{2k_B T} \right) + \tanh \left( \frac{hx - E_F}{2k_B T} \right) \right]$.

In this description, there are two parameters describing the state of the graphene: the Fermi energy (or, rigorously, the chemical potential) $E_F$ and the carrier scattering rate $\gamma$. In our simulations, we chose $E_F = 0.3$ eV, a value comparable to the range of 0.25–0.35 eV measured by terahertz spectroscopy for unintentionally doped and transferred graphene layers. For the scattering rate, we used $\gamma = 2.0 \times 10^{13}$ s$^{-1}$, close to experimentally measured value of $\gamma = 2.3 \times 10^{13}$ s$^{-1}$ for CVD graphene (see Supporting Information, Figure S2c).

### Plasmonic Regime

In the mid-IR spectral region, we expect light–matter interactions to be dominated by the plasmonic modes of graphene. For our structures, the lattice constant $a$ is much smaller than the wavelength of the light in this spectral range, so the membrane can be considered to be an effective homogeneous dielectric layer for the optical (but not plasmonic) waves (Supporting Information, Figure S2d, for the effective refractive index). For a free-space wavelength of $\lambda_0 = 10 \mu$m (1000 cm$^{-1}$), the effective wavelengths for the plasmons in graphene are 352 and 54 nm for the supported and suspended regions, respectively, with corresponding propagation lengths of 264 and 41 nm (see Supporting Information, Figure S3).

Strong plasmonic coupling can occur if the size of a resonator in the structure is nearly equal to an integral number of effective wavelengths of the guided wave. In the case of a hole radius of $r = 100$ nm, the size of the silicon region between the edges of nearest neighboring holes is 215 nm. Based on these simple considerations, we expect to be able to excite the second-order plasmonic mode (with an effective wavelength about 112 nm around 700 cm$^{-1}$) at the silicon–graphene–air interface. (Excitation of the first-order mode would lie below 500 cm$^{-1}$ and is consequently outside of our experimental spectral range.) Plasmons can also be excited at the air–graphene–air interface at higher frequencies, with the first-order resonance occurring at a frequency around 1200 cm$^{-1}$. Due to the short propagation
length of the plasmon, the quality factor of the resonator is expected to be relatively low and the resonance broad. These expectations are confirmed by our experiment and simulations, as shown in Figure 2a,b. The plasmonic peak in the range below 1000 cm⁻¹ exhibits a gradual blue shift with increasing hole radius, that is, with decreasing size of the supported graphene layer. This basic trend, shown by blue arrows in Figure 2, is consistent with excitation of silicon–graphene–air plasmonic modes. The inset in Figure 2b shows the rapid in-plane spatial oscillations of the electric field distribution at the associated resonance, corresponding to the second-order plasmonic mode in the supported graphene layer. The peak near 1100 cm⁻¹ is associated with a well-known phonon resonance in silica. At this frequency the reflectances $R$ and $R_0$ are close to zero, which leads to errors in calculating the extinction ratio $ER = 1 - R/R_0$. Near 1100 cm⁻¹, a local maximum is predicted in the simulations for a hole radius of 80 nm, while a local minimum is expected for the other hole radii (see Figure 2b). In the experiment spectra, however, only a local maximum is observed (Figure 2a). The strong absorption of silica suppresses the air–graphene–air plasmonic resonances that would otherwise be expected in the range above 1200 cm⁻¹.

### PHOTONIC REGIME

For a Fermi energy of $E_F = 0.3$ eV, interband transitions turn on for frequencies above 4830 cm⁻¹. In the higher-frequency range of 5500–7700 cm⁻¹, where photonic crystal resonances are present, graphene then behaves as an absorptive material with a nearly constant real sheet conductivity of $\sigma_S(\omega) = \sigma_0 = e^2/4\hbar$. The measured extinction spectra $ER = 1 - R/R_0$ in Figure 3a exhibit a resonance corresponding to the first Fabry–Perot photonic resonance (compare the frequency position of the resonance to the kink in effective index of the membrane in Figure S2d). The feature in the extinction spectra exhibits a systematic blue shift with increasing hole radius. The experimental spectra (Figure 3a) could be fit well by Fano line shapes. Figure 3b shows the corresponding simulation of our structure. The structure consists of several relatively thick layers (the 250 nm thick silicon photonic crystal membrane, a 500 nm thick air gap, and the 1500 nm thick silica layer above...
Article

Figure 4. Calculated enhancement of absorption by plasmonic effects in mid-IR range. (a) Absorption of graphene (with $E_F = 0.7$ eV) on a silicon photonic crystal membrane ($a = 100$ nm, $w/a = 0.1$, $t = 100$ nm) with (red dotted curve) and without (gray solid curve) a back mirror reflector (with an air gap of 1600 nm). The field profiles at certain frequencies are shown in the inset. A maximum absorption of 87% is achieved by increasing Fermi level in graphene to 0.7 eV and setting the air gap thickness to 1600 nm (see the inset of b). (b) Absorption peak for four plasmonic modes (1–4, see panel a) vs the thickness of the air gap.

the bulk silicon substrate, see Figure S1). The presence of these layers leads to multiple resonances in the spectral range of the measurements (see Supporting Information). However, a single resonance has a dominant contribution in the experimental frequency range of 5500−7700 cm$^{-1}$. The simulations (Figure 3b) are seen to reproduce the observed blue shifts with increasing hole radius. The electric field distribution is illustrated in the inset of Figure 3b, which shows that the field is concentrated around the graphene layer, thus maximizing its interaction with the photonic mode.

To explore designs for optimized absorbance, we consider graphene on a simplified one-dimensional photonic crystal (Figure 4) with period $a$, thickness $t$, and air hole width $w$. The dependence of the absorbance on these structural parameters is discussed in the Supporting Information S1.3. The electric fields at resonant frequencies represent the whole range of possible surface plasmonic modes (Figure 4a, gray curve), including silicon−graphene−air and air−graphene−air modes, mixed modes, and photonic modes (see the inset for the field maps).

In the case of coupling to the photonic modes, a reasonable approach is to optimize the geometrical parameters so that the photonic modes confined in the photonic crystal plane can achieve higher quality factors. For example, increasing the period $a$ to 500 nm for a thick silicon membrane of $t = 500$ nm causes the absorbance to grow from a few percent to 18% (see Supporting Information, S1.3). The absorption can be maximized by satisfying the critical coupling criterion in which the photon loss rate from leakage equals the graphene absorption.$^{29,30,47}$ Such solutions are, however, difficult in the plasmonic regime, since plasmonic modes experience greater damping rates.

An alternative approach to increasing the absorbance in both the plasmonic and photonic regimes is to use a back reflector (red curve in Figure 4a). The quality factor of all optical modes (shown in the insets of Figure 4a) can be improved using a back reflector, with a controlled air gap between the silicon membrane and metal reflector. For example, adding a metallic mirror with an air spacer of thickness $t_{air} = 1600$ nm below the $t = 100$ nm thick membrane with graphene ($E_F = 0.7$ eV) induces an increase in absorption from 18 to 87%, as shown in Figure 4a. For higher doping levels, the absorption for each plasmonic mode is maximized for a specific air gap thickness (Figure 4b).

As we have shown in this paper, graphene combined with a photonic crystal membrane offers a rich playground for controlling light−matter interactions in a platform compatible with silicon-based CMOS fabrication technology. We have delineated several different regimes for the enhancement of the absorption of IR radiation of a graphene monolayer placed on a silicon membrane patterned with a two-dimensional photonic crystal lattice. The enhancement, as observed experimentally and predicted theoretically, is a direct consequence of light coupling to plasmonic and photonic modes.

We have classified various regimes of light interaction for the graphene−photonic crystal composite structure: the metamaterial, plasmonic, photonic, and diffraction grating regimes, according to the relation of their effective wavelengths to the structural parameters of the photonic crystal. These different regimes may be suitable for different applications. The metamaterial regime, mainly in the terahertz to mid-IR range, may be of value for tunable absorbers, filters, and modulators. The plasmonic regime in mid-IR can be used, in addition to the aforementioned applications, for sensing due to the extreme confinement of graphene plasmons close to the surface. The photonic regime is suitable for photodetection, since absorption of photons in graphene may generate a photocurrent.

ASSOCIATED CONTENT

Supporting Information

The Supporting Information is available free of charge on the ACS Publications website at DOI: 10.1021/acsphotonics.5b00209.

Simulated materials and structures; graphene plasmon properties; absorbance of graphene-covered 1D silicon subwavelength gratings; Raman characterization of the graphene-on-photonic crystal structures; effective index calculations and the reflectivity of multilayer structures; Fano fits to the substrate guided modes in near-IR region (PDF).
The authors thank Z. Huang and C. Li at Hewlett-Packard Laboratories for valuable discussions and Carlos Forsythe at The Danish Council for Technical and Production Sciences through the GraTer Project (Contract No. 0602-02135B).

ACKNOWLEDGMENTS

The authors declare no competing financial interest.

REFERENCES

(1) Reed, G. T.; Knights, A. P. Silicon Photonics; Wiley Online Library: New York, 2008.


